Test Report issued under the responsibility of:



TEST REPORT IEC 62471 Photobiological safety of lamps and lamp systems

1 11010510109104				
Report Reference No	16-10-05			
Date of issue:	2016-10-10			
Total number of pages:				
Testing Laboratory	SAMSUNG ELETRONICS Co., Ltd.			
Address	1, Samsung-ro, Giheung-gu, Yongin-si, Gyeonggi-do, 17113, Korea			
Applicant's name:	SAMSUNG ELETRONICS Co., Ltd.			
Address	129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea			
Test specification:				
Standard:	IEC 62471:2006 (First Edition)			
Test procedure:	N/A			
Non-standard test method	N/A			
Test Report Form No	IEC62471A			
TRF Originator	VDE Testing and Certification Institute			
Master TRF	Dated 2009-05			
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This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02.				
Test item description	LED PKG			
Trade Mark:	SAMSUNG			
Manufacturer	Same as Testing Laboratory			
Model/Type reference:	SPHWHAHDNM251ZR3U2			
Ratings	DC 1 620 mA / 50,53 V			

Testi	Testing procedure and testing location:			
\square	Testing Laboratory:	SAMSUNG ELETRONICS Co., Ltd. (LED Biz.)		
Test	ing location/ address	1, Samsung-ro, Giheung-gu, Yongin-si, Gyeonggi-do, 17113, Korea		
	Associated Laboratory:			
Testing location/ address:				
	Tested by (name + signature):			
	Approved by (+ signature):			
	Testing procedure: TMP			
	Tested by (name + signature):			
	Approved by (+ signature):			
Test	ing location/ address			
	Testing procedure: WMT			
	Tested by (name + signature) :			
	Witnessed by (+ signature):			
	Approved by (+ signature):			
Testing location/ address:				
	Testing procedure: SMT			
	Tested by (name + signature):			
	Approved by (+ signature):			
	Supervised by (+ signature):			
Test	ing location/ address:			
	Testing procedure: RMT			
	Tested by (name + signature):			
	Approved by (+ signature):			
	Supervised by (+ signature):			
Test	Testing location/ address:			

Summary of testing:			
ests performed (name of test and test clause):	Testing location:		
- The sample was applied DC 1 620mA fol-	SAMSUNG ELETRONICS Co., Ltd		
 lowing by applicant request. The measurement was conducted according to the requirements of TR IEC/EN62778 in conjunction with IEC 62471. All relevant clauses were considered. 	1, Samsung-ro, Giheung-gu, Yongin-si, Gyeonggi-do, 17113, Korea		
- The sample was measured at 122℃(tc).			
mmary of compliance with National Differences	<u> </u>		
e sample(s) tested complies with the requirements	of IEC 62471:2006 and EN 62471:2008		
e Attachment at the end of this report for complian			
fferences.			
opy of marking plate:			
opy of marking plate.			

Test item particulars:				
Tested lamp	: 🖾 continuous wave lamps 🛛 🗌 pulsed lamps			
Tested lamp system:				
Lamp classification group:	🗌 exempt 🛛 🖾 risk 1 📄 risk 2 🗌 risk 3			
Lamp cap	:			
Bulb	: LED			
Rated of the lamp:	See Page 1			
Furthermore marking on the lamp:				
Seasoning of lamps according IEC standard:				
Used measurement instrument:				
Temperature by measurement:	24,0 – 25,0 °C			
Information for safety use:	Not required			
Possible test case verdicts:				
- test case does not apply to the test object	N/A			
- test object does meet the requirement	P (Pass)			
- test object does not meet the requirement	F (Fail)			
Testing:				
Date of receipt of test item	2016-10-04			
Date (s) of performance of tests	2016-10-05 ~ 2016-10-07			
General remarks:				
The test results presented in this report relate only to the object tested. This report shall not be reproduced, except in full, without the written approval of the Issuing testing laboratory. "(See Enclosure #)" refers to additional information appended to the report. "(See appended table)" refers to a table appended to the report. Throughout this report a comma (point) is used as the decimal separator. List of test equipment must be kept on file and available for review.				
General product information:				
 Tested products are LED PKG as a light source, model information can be found in the table on next page. The following PKG is tested as representative model. PKG : LC080D CCT : 5000K CRI : 80 				
 Flux rank : U2 Tested current : DC 1 620 mA A photo of test sample. 				
Throughout this report a 🖾 comma / 🗌 point is used as the decimal separator.				